



# 3.3V CMOS 16-BIT REGISTERED TRANSCEIVER WITH 3-STATE OUTPUTS AND BUS-HOLD

**IDT74ALVCH16543**

## FEATURES:

- 0.5 MICRON CMOS Technology
- Typical  $t_{sk(o)}$  (Output Skew) < 250ps
- ESD > 2000V per MIL-STD-883, Method 3015; > 200V using machine model (C = 200pF, R = 0)
- $V_{cc} = 3.3V \pm 0.3V$ , Normal Range
- $V_{cc} = 2.7V$  to  $3.6V$ , Extended Range
- $V_{cc} = 2.5V \pm 0.2V$
- CMOS power levels ( $0.4\mu W$  typ. static)
- Rail-to-Rail output swing for increased noise margin
- Available in SSOP, TSSOP, and TVSOP packages

## DRIVE FEATURES:

- High Output Drivers:  $\pm 24mA$
- Suitable for heavy loads

## APPLICATIONS:

- 3.3V high speed systems
- 3.3V and lower voltage computing systems

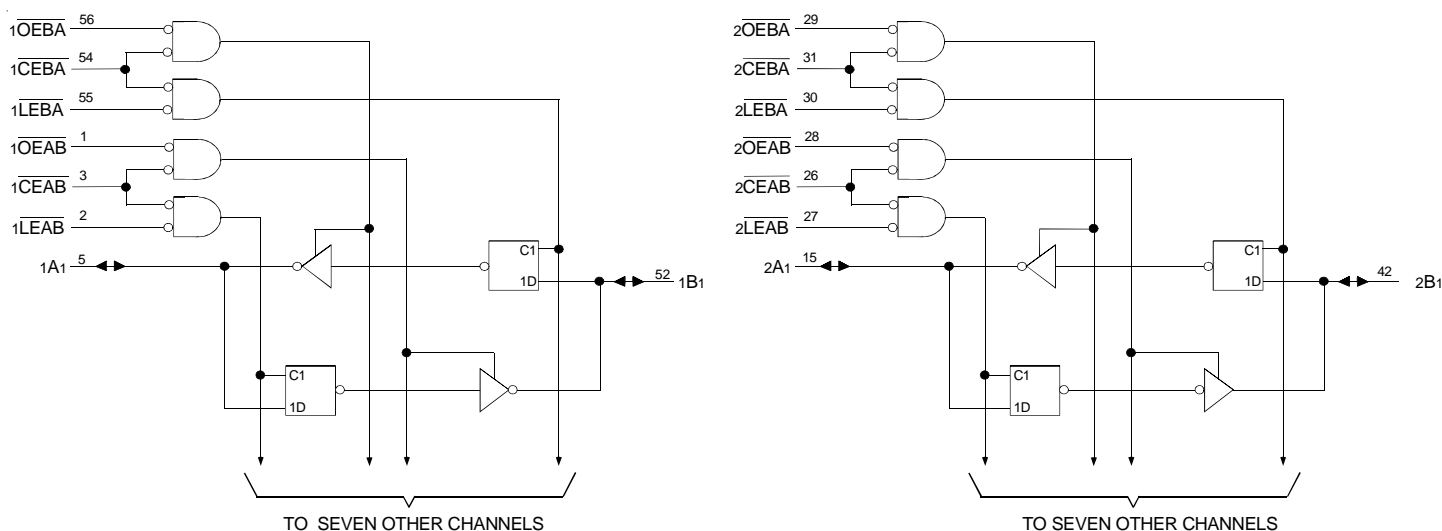
## DESCRIPTION:

This 16-bit registered transceiver is built using advanced dual metal CMOS technology. The ALVCH16543 can be used as two 8-bit transceivers or one 16-bit transceiver. Separate latch-enable ( $\overline{LEAB}$  or  $\overline{LEBA}$ ) and output-enable ( $\overline{OEAB}$  or  $\overline{OEBA}$ ) inputs are provided for each register to permit independent control in either direction of data flow. The A-to-B enable ( $\overline{CEAB}$ ) input must be low to enter data from A or to output data from B. If  $\overline{CEAB}$  is low and  $\overline{LEAB}$  is low, the A-to-B latches are transparent; a subsequent low-to-high transition of  $\overline{LEAB}$  puts the A latches in the storage mode. With  $\overline{CEAB}$  and  $\overline{OEAB}$  both low, the 3-state B outputs are active and reflect the data present at the output of the A latches. Data flow from B to A is similar, but requires using  $\overline{CEBA}$ ,  $\overline{LEBA}$ , and  $\overline{OEBA}$ .

The ALVCH16543 has been designed with a  $\pm 24mA$  output driver. This driver is capable of driving a moderate to heavy load while maintaining speed performance.

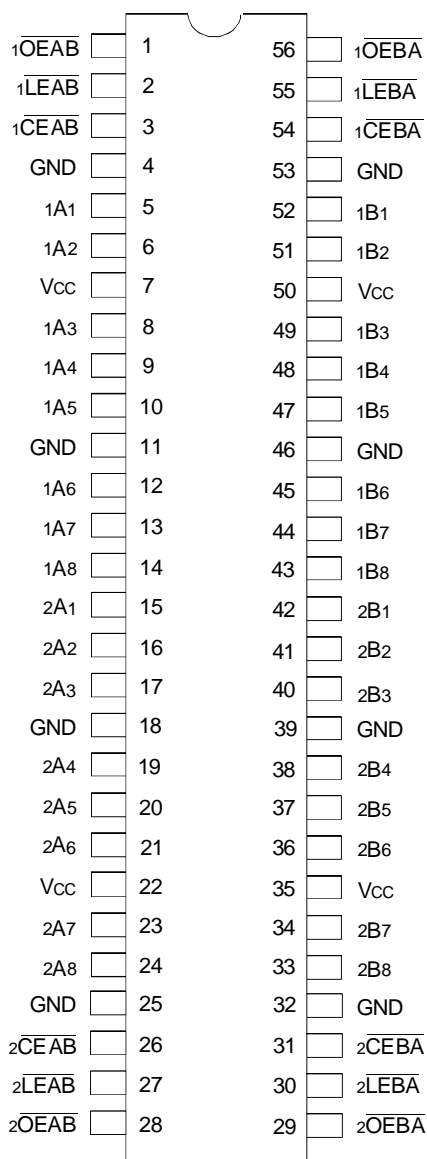
The ALVCH16543 has "bus-hold" which retains the inputs' last state whenever the input bus goes to a high impedance. This prevents floating inputs and eliminates the need for pull-up/down resistors.

## FUNCTIONAL BLOCK DIAGRAM



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## PIN CONFIGURATION



SSOP/ TSSOP/ TVSOP  
TOP VIEW

## PIN DESCRIPTION

Pin Names	Description
$\overline{xOEAB}$	A-to-B Output Enable Inputs (Active LOW)
$\overline{xOEB\overline{A}}$	B-to-A Output Enable Inputs (Active LOW)
$\overline{xCEAB}$	A-to-B Enable Inputs (Active LOW)
$\overline{xCEB\overline{A}}$	B-to-A Enable Inputs (Active LOW)
$\overline{xLEAB}$	A-to-B Latch Enable Inputs (Active LOW)
$\overline{xLEB\overline{A}}$	B-to-A Latch Enable Inputs (Active LOW)
$xAx$	A-to-B Data Inputs or B-to-A 3-State Outputs <sup>(1)</sup>
$xBx$	B-to-A Data Inputs or A-to-B 3-State Outputs <sup>(1)</sup>

### NOTE:

1. These pins have "Bus-Hold". All other pins are standard inputs, outputs, or I/Os.

## ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

Symbol	Description	Max	Unit
$V_{TERM}^{(2)}$	Terminal Voltage with Respect to GND	-0.5 to +4.6	V
$V_{TERM}^{(3)}$	Terminal Voltage with Respect to GND	-0.5 to $V_{CC}+0.5$	V
TSTG	Storage Temperature	-65 to +150	°C
I <sub>OUT</sub>	DC Output Current	-50 to +50	mA
I <sub>IK</sub>	Continuous Clamp Current, $V_I < 0$ or $V_I > V_{CC}$	±50	mA
I <sub>OK</sub>	Continuous Clamp Current, $V_O < 0$	-50	mA
I <sub>CC</sub> I <sub>SS</sub>	Continuous Current through each $V_{CC}$ or GND	±100	mA

### NOTES:

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- $V_{CC}$  terminals.
- All terminals except  $V_{CC}$ .

## CAPACITANCE ( $T_A = +25^\circ\text{C}$ , $F = 1.0\text{MHz}$ )

Symbol	Parameter <sup>(1)</sup>	Conditions	Typ.	Max.	Unit
C <sub>IN</sub>	Input Capacitance	$V_{IN} = 0V$	5	7	pF
C <sub>OUT</sub>	Output Capacitance	$V_{OUT} = 0V$	7	9	pF
C <sub>I/O</sub>	I/O Port Capacitance	$V_{IN} = 0V$	7	9	pF

### NOTE:

- As applicable to the device type.

## FUNCTION TABLE<sup>(1,2)</sup>

Inputs				Output
$\overline{xCEAB}$	$\overline{xLEAB}$	$\overline{xOEAB}$	$xAx$	$xBx$
X	X	X	X	Z
X	X	H	X	Z
L	H	L	X	B <sup>(3)</sup>
L	L	L	L	L
L	L	L	H	H

### NOTES:

- A-to-B data flow is shown. B-to-A data flow is similar but uses  $\overline{xCEB\overline{A}}$ ,  $\overline{xLEB\overline{A}}$ , and  $\overline{xOEB\overline{A}}$ .
- H = HIGH Voltage Level  
L = LOW Voltage Level  
X = Don't Care  
Z = High-Impedance
- Level of B before the indicated steady-state inputs were established.

## DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:

Operating Condition:  $T_A = -40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$

Symbol	Parameter	Test Conditions		Min.	Typ. <sup>(1)</sup>	Max.	Unit
V <sub>IH</sub>	Input HIGH Voltage Level	V <sub>CC</sub> = 2.3V to 2.7V		1.7	—	—	V
		V <sub>CC</sub> = 2.7V to 3.6V		2	—	—	
V <sub>IL</sub>	Input LOW Voltage Level	V <sub>CC</sub> = 2.3V to 2.7V		—	—	0.7	V
		V <sub>CC</sub> = 2.7V to 3.6V		—	—	0.8	
I <sub>IH</sub>	Input HIGH Current	V <sub>CC</sub> = 3.6V	V <sub>I</sub> = V <sub>CC</sub>	—	—	±5	μA
I <sub>IL</sub>	Input LOW Current	V <sub>CC</sub> = 3.6V	V <sub>I</sub> = GND	—	—	±5	μA
I <sub>OZH</sub> I <sub>OZL</sub>	High Impedance Output Current (3-State Output pins)	V <sub>CC</sub> = 3.6V		—	—	±10	μA
		V <sub>O</sub> = GND		—	—	±10	
V <sub>IK</sub>	Clamp Diode Voltage	V <sub>CC</sub> = 2.3V, I <sub>IN</sub> = -18mA		—	-0.7	-1.2	V
V <sub>H</sub>	Input Hysteresis	V <sub>CC</sub> = 3.3V		—	100	—	mV
I <sub>CC1</sub> I <sub>CC2</sub> I <sub>CC3</sub>	Quiescent Power Supply Current	V <sub>CC</sub> = 3.6V V <sub>IN</sub> = GND or V <sub>CC</sub>		—	0.1	40	μA
ΔI <sub>CC</sub>	Quiescent Power Supply Current Variation	One input at V <sub>CC</sub> - 0.6V, other inputs at V <sub>CC</sub> or GND		—	—	750	μA

**NOTE:**

1. Typical values are at V<sub>CC</sub> = 3.3V, +25°C ambient.

## BUS-HOLD CHARACTERISTICS

Symbol	Parameter <sup>(1)</sup>	Test Conditions		Min.	Typ. <sup>(2)</sup>	Max.	Unit	
I <sub>BHH</sub> I <sub>BHL</sub>	Bus-Hold Input Sustain Current	V <sub>CC</sub> = 3V		—	—	—	μA	
		V <sub>I</sub> = 0.8V		-75	—	—		
I <sub>BHH</sub> I <sub>BHL</sub>	Bus-Hold Input Sustain Current	V <sub>CC</sub> = 2.3V		—	—	—	μA	
		V <sub>I</sub> = 0.7V		-45	—	—		
I <sub>BHHO</sub> I <sub>BHLO</sub>	Bus-Hold Input Overdrive Current	V <sub>CC</sub> = 3.6V		V <sub>I</sub> = 0 to 3.6V		—	±500	μA

**NOTES:**

1. Pins with Bus-Hold are identified in the pin description.
2. Typical values are at V<sub>CC</sub> = 3.3V, +25°C ambient.

## OUTPUT DRIVE CHARACTERISTICS

Symbol	Parameter	Test Conditions <sup>(1)</sup>		Min.	Max.	Unit
VOH	Output HIGH Voltage	VCC = 2.3V to 3.6V	IOH = - 0.1mA	VCC - 0.2	—	V
		VCC = 2.3V	IOH = - 6mA	2	—	
		VCC = 2.3V	IOH = - 12mA	1.7	—	
		VCC = 2.7V		2.2	—	
		VCC = 3V		2.4	—	
		VCC = 3V	IOH = - 24mA	2	—	
VOL	Output LOW Voltage	VCC = 2.3V to 3.6V	IOL = 0.1mA	—	0.2	V
		VCC = 2.3V	IOL = 6mA	—	0.4	
			IOL = 12mA	—	0.7	
		VCC = 2.7V	IOL = 12mA	—	0.4	
		VCC = 3V	IOL = 24mA	—	0.55	

**NOTE:**  
1. VIH and VIL must be within the min. or max. range shown in the DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE table for the appropriate VCC range. TA = - 40°C to + 85°C.

## OPERATING CHARACTERISTICS, TA = 25°C

Symbol	Parameter	Test Conditions	VCC = 2.5V ± 0.2V	VCC = 3.3V ± 0.3V	Unit
			Typical	Typical	
CPD	Power Dissipation Capacitance Outputs enabled	CL = 0pF, f = 10Mhz	54	64	pF
CPD	Power Dissipation Capacitance Outputs disabled		6	7	

SWITCHING CHARACTERISTICS<sup>(1)</sup>

Symbol	Parameter	V <sub>CC</sub> = 2.5V ± 0.2V		V <sub>CC</sub> = 2.7V		V <sub>CC</sub> = 3.3V ± 0.3V		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay xAx to xBx or xBx to xAx	1	5.1	—	4.8	1	4.3	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay xLEAB to xBx or xLEAB to xAx	1	6.5	—	6.2	1.1	5	ns
t <sub>PZH</sub> t <sub>PZL</sub>	Output Enable Time xCEAB to xBx or xCEAB to xAx	1	7.2	—	6.9	1	5.6	ns
t <sub>PHZ</sub> t <sub>PLZ</sub>	Output Disable Time xCEAB to xBx or xCEAB to xAx	1.3	6.1	—	6.2	1.5	5.1	ns
t <sub>PZH</sub> t <sub>PZL</sub>	Output Enable Time xOEAB to xBx or xOEAB to xAx	1	6.8	—	6.3	1	5.3	ns
t <sub>PHZ</sub> t <sub>PLZ</sub>	Output Disable Time xOEAB to xBx or xOEAB to xAx	1	5.7	—	4.8	1.1	4.6	ns
t <sub>SU</sub>	Set-up Time, data before CE↑	1.2	—	1.5	—	1.2	—	ns
t <sub>SU</sub>	Set-up Time, data before LE↑, CE LOW	1.2	—	1.5	—	1.2	—	ns
t <sub>H</sub>	Hold Time, Ax data after CE↑	1.2	—	0.8	—	1.3	—	ns
t <sub>H</sub>	Hold Time, Bx data after LE↑, CE LOW	1.2	—	0.8	—	1.3	—	ns
t <sub>w</sub>	Pulse Duration, LE or CE LOW	3.3	—	3.3	—	3.3	—	ns
t <sub>sk(o)</sub>	Output Skew <sup>(2)</sup>	—	—	—	—	—	500	ps

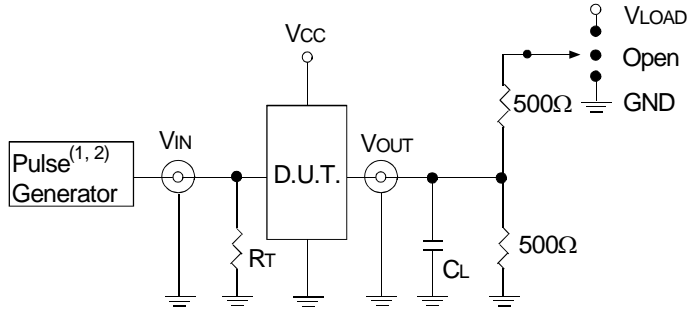
NOTES:

1. See TEST CIRCUITS AND WAVEFORMS. T<sub>A</sub> = - 40°C to + 85°C.
2. Skew between any two outputs of the same package and switching in the same direction.

## TEST CIRCUITS AND WAVEFORMS

### TEST CONDITIONS

Symbol	V <sub>CC</sub> <sup>(1)</sup> =3.3V±0.3V	V <sub>CC</sub> <sup>(1)</sup> =2.7V	V <sub>CC</sub> <sup>(2)</sup> =2.5V±0.2V	Unit
V <sub>LOAD</sub>	6	6	2 x V <sub>CC</sub>	V
V <sub>IH</sub>	2.7	2.7	V <sub>CC</sub>	V
V <sub>T</sub>	1.5	1.5	V <sub>CC</sub> / 2	V
V <sub>LZ</sub>	300	300	150	mV
V <sub>HZ</sub>	300	300	150	mV
C <sub>L</sub>	50	50	30	pF



Test Circuit for All Outputs

#### DEFINITIONS:

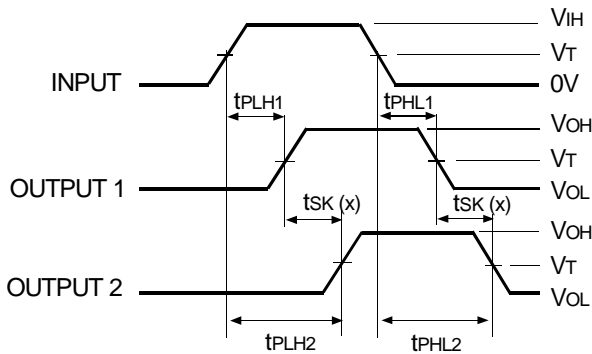
C<sub>L</sub> = Load capacitance: includes jig and probe capacitance.  
R<sub>T</sub> = Termination resistance: should be equal to Z<sub>OUT</sub> of the Pulse Generator.

#### NOTES:

1. Pulse Generator for All Pulses: Rate ≤ 1.0MHz; t<sub>r</sub> ≤ 2.5ns; t<sub>r</sub> ≤ 2.5ns.
2. Pulse Generator for All Pulses: Rate ≤ 1.0MHz; t<sub>r</sub> ≤ 2ns; t<sub>r</sub> ≤ 2ns.

### SWITCH POSITION

Test	Switch
Open Drain Disable Low Enable Low	V <sub>LOAD</sub>
Disable High Enable High	GND
All Other Tests	Open

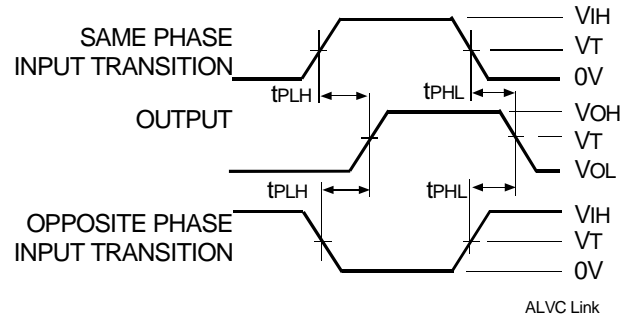


$$tsk(x) = |t_{PLH2} - t_{PLH1}| \text{ or } |t_{PHL2} - t_{PHL1}|$$

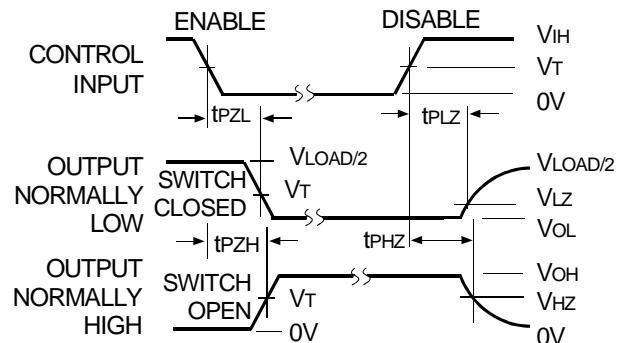
Output Skew - tsk(x)

#### NOTES:

1. For tsk(o) OUTPUT1 and OUTPUT2 are any two outputs.
2. For tsk(b) OUTPUT1 and OUTPUT2 are in the same bank.



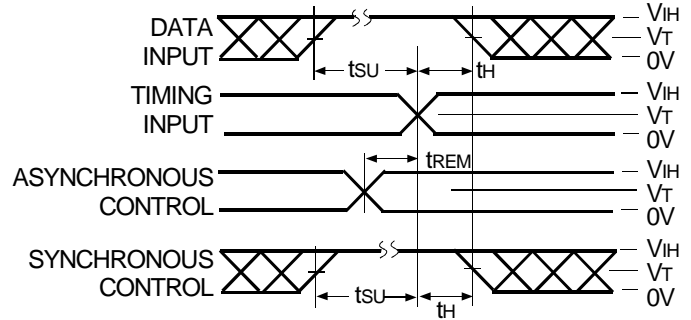
Propagation Delay



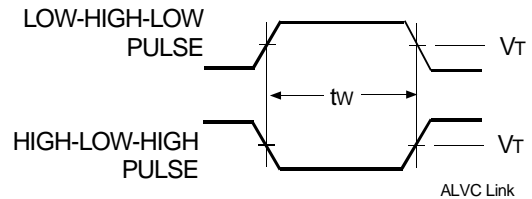
Enable and Disable Times

#### NOTE:

1. Diagram shown for input Control Enable-LOW and input Control Disable-HIGH.



Set-up, Hold, and Release Times



Pulse Width

